Simulation of dN/dx with TPC

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dN/dx in gaseous detectors

In time

- Time measurement in small drift cells of DC
- Challenging of fast-shaping electronics (~ns needed)
- De-couple the charge collection from the cluster counting altogether
- →optical, with ~(sub) ns continuous readout sensors

In space

- Resolve clusters in space by high granularity TPC
- Challenging of the low power consumption electronics (>40 mV/fC needed at 2000 of gas gain)
- Pixelated readout high granularity
- → the reasonable pixilation reveals the underlying cluster structure in 3D chamber





Simulation framework



Simulation/Digitization

Reconstruction

Parametrizations

- Diffusion:
 - σ_T vs drift distance
 - σ_X vs drift distance
 - σ_{Y} vs drift distance
- Amplification:
 - Particle number: Polya function sampling with 2000 gain
 - Space resolution: 120 μm
- Electronics noise:
 - 100 e⁻/pad



MC-truth-level readout



- MC-truth-level readout with simplified amplification and shaping model
- Color code indicates the cluster ID
- Note:
 - Most electrons are separatable
 - Electrons from the same cluster are spatially localized

Reconstruction by threshold passing

- By using a threshold-based method, preliminary reconstruction of clusters can be achieved
- The drift distance does not affect the threshold setting
- The reconstruction efficiency is related to the particle drift distance and requires calibration. (The reconstruction efficiency is 90% when
 the drift distance is 100 cm, and 60% when the drift distance is 50 cm).







dN/dx performance

- Investigating the π/K discrimination capability using reconstructed clusters, a 3σ separation at 20GeV with a 50cm drift distance can be achieved
- dN/dx has significant potential for improving resolution



To do (I): Pad size optimization

 dN/dx (and tracking) can be beneficial from smaller pad size

 $\rho_{cl} \approx 30 cm^{-1} \Rightarrow Pad size \approx 300 \mu m$ (To detect single e⁻)

 Need to find out the optimal pad size considering cost/power consumption Simulation with 30 cm track length



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To do (II): Understand the 2021 DESY test beam

2021 DESY test beam: dN/dx resolution TimePix3 Readout: 55x55 µm 5-6 GeV/c electron beam tracks 250 B=1 T data MIP scale corrected QUAD design and realization electron resolution 200 4.2% Four-TimePix3 chips 39.6 x 28.38 mm Preliminary 150 [electron has 2.9%] All services (signal IO, LV) series of QUADs power) are located under the detection surface Guard 100 The area for connections 1 m track 60% and was squeezed to the minimum coverage 50 Very high precision 10 µm TPX3 TPX3 mounting of the chips and quard COld QUAD has a sensitive area 0.05 0.1 0.2 0.15 0.25 of 68.9% CArrier DAQ by SPIDR fitted slope [1/pixels] Note: LCTPC DESY March 2024 Advance algorithm (20% better than threshold passing) •

Advance algorithm (20% better than threshold pase)
Drift length < 4 cm, very small diffusion

To do (II): Understand the 2021 DESY test beam

Need to understand their results and tune our simulation!

Extremely powerful PID performance:

> 6σ @ 20 GeV/c, 1.4 m track length



ILD detector

rInner = 329 rOuter = 1770 mm

MIP resolution = 3.6% at $\theta = \pi/2$

electron resolution = 2.5%

Assume Pixel TPC performance at B = 1 T at p = 5,6 GeV/c

- Separation pion kaon |<Eloss π > - <Eloss K>| / σ_{π}
- Separation pion kaon for different cos(theta) values due to the track length dependence
- For cos(theta)=0 till 0.95 the separation lies between the black and red curves. Only above 0.95-0.975 the separation drops till the blue curve.
- Excellent performance over very large polar angle range

Backup

dE/dx extrapolation from test beam

- A higher granularity is also very helpful for improving dE/dx.
- According to simulation results, for a pad size of 500um, with the current 1.2-meter track length of CEPC, the dE/dx can reach 3.2%.



$$\sigma_{dE/dx} \sim L^{-0.47} \times G^{-0.13}$$

